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### Optical components for ghost image suppression systems and methods

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#### Abstract

Various techniques are disclosed to provide for reducing undesired reflections in captured images. In one example, a system includes an optical element configured to pass radiation from a scene. The system also includes an imager configured to capture images in response to the scene radiation and reflect at least a portion of the scene radiation to the optical element. The optical element comprises a surface with a convex radius of curvature facing the imager and configured to receive and return the reflected radiation toward the imager in a distribution pattern to reduce a magnitude of the reflected radiation in the captured images. Additional methods, devices, and systems are also provided.

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## Background/Summary

CROSS REFERENCE TO RELATED APPLICATIONS (1) This application claims priority to and the benefit of U.S. Provisional Patent Application No. 63/169,011 filed Mar. 31, 2021 and entitled “OPTICAL COMPONENTS FOR GHOST IMAGE SUPPRESSION SYSTEMS AND METHODS,” which is hereby incorporated by reference in its entirety.

### TECHNICAL FIELD

(1) The present invention relates generally to image capture and, more particularly, to the reduction of undesired reflections in captured images.

## BACKGROUND

(2) In imaging systems, radiation from a scene may be received and captured by an imager. In some cases, at least a portion of the original radiation may be reflected internally within the imaging system. As a result, the imager may capture images that include a feature of the scene represented twice: a first representation from the originally received radiation; and a second representation (e.g., a “ghost image”) from the reflected radiation.

(3) For example, when hot bright sources of infrared radiation are imaged by a thermal imaging camera with a protective window positioned close to its pupil, infrared radiation may pass through the protective window, reflect off a vacuum package lid of a thermal imager, reflect back off the protective window, and be captured by the thermal imager as a ghost image.

(4) Although anti-reflective coatings may be employed on the protective window and the vacuum package lid, they may not be effective at attenuating all reflected wavelengths. For example, certain microbolometer-based thermal imagers may be responsive over a wide wavelength range (e.g., 5 microns to 14 microns). However, some anti-reflective coatings may only be effective over a limited subset of such range (e.g., 8 microns to 14 microns). As a result, thermal imagers may be susceptible to capturing ghost images even if anti-reflective coatings are provided on the protective window, package lid, or other portions of a thermal imaging system.

## SUMMARY

(5) Various techniques are disclosed to provide for reducing undesirable reflections within imaging systems. In particular, various optical systems may be included with one or more optical elements configured to reduce such reflections. For example, in some embodiments, a curved protective window having a curved inner surface with a convex radius of curvature may be provided to defocus reflected radiation in a wide distribution pattern such that it is less prominent in captured images. In another example, a filter may be provided to attenuate reflected radiation.

(6) In one embodiment, a system includes an optical element configured to pass radiation from a scene; an imager configured to capture images in response to the scene radiation and reflect at least a portion of the scene radiation to the optical element; and wherein the optical element comprises a surface with a convex radius of curvature facing the imager and configured to receive and return the reflected radiation toward the imager in a distribution pattern to reduce a magnitude of the reflected radiation in the captured images.

(7) In another embodiment, a method includes passing radiation from a scene by an optical element; capturing images in response to the scene radiation by an imager; reflecting at least a portion of the scene radiation to the optical element by the imager; receiving the reflected radiation at a surface of the optical element having a convex radius of curvature facing the imager; and returning the reflected radiation toward the imager by the surface of the optical element in a distribution pattern to reduce a magnitude of the reflected radiation in the captured images.

(8) In another embodiment, a method includes passing radiation from a scene by an optical element; capturing images in response to the scene radiation by an imager; reflecting at least a portion of the scene radiation to the optical element by the imager; and reducing, by the optical element, a magnitude of the reflected radiation in the captured images.

(9) The scope of the invention is defined by the claims, which are incorporated into this section by reference. A more complete understanding of embodiments of the invention will be afforded to those skilled in the art, as well as a realization of additional advantages thereof, by a consideration of the following detailed description of one or more embodiments. Reference will be made to the appended sheets of drawings that will first be described briefly.

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## Description

## BRIEF DESCRIPTION OF THE DRAWINGS

- (1) FIG. 1 illustrates a block diagram of an imaging system in accordance with an embodiment of the disclosure.
- (2) FIGS. 2 and 3 illustrate radiation paths in an imaging system having a flat protective window in accordance with embodiments of the disclosure.
- (3) FIG. 4 illustrates a polychromatic fast Fourier transform of a point spread function of radiation captured by the imaging system of FIG. 2 in accordance with an embodiment of the disclosure.
- (4) FIG. 5 illustrates an image of radiation captured by the imaging system of FIG. 2 in accordance with an embodiment of the disclosure.
- (5) FIG. 6 illustrates response plots of radiation captured by the imaging system of FIG. 2 in accordance with an embodiment of the disclosure.
- (6) FIGS. 7 and 8 illustrate radiation paths in an imaging system having a curved protective window in accordance with embodiments of the disclosure.
- (7) FIG. 9 illustrates a polychromatic fast Fourier transform of a point spread function of radiation captured by the imaging system of FIG. 7 in accordance with an embodiment of the disclosure.
- (8) FIG. 10 illustrates an image of radiation captured by the imaging system of FIG. 7 in accordance with an embodiment of the disclosure.
- (9) FIG. 11 illustrates response plots of radiation captured by the imaging system of FIG. 7 in accordance with an embodiment of the disclosure.
- (10) FIG. 12 illustrates an imaging system having a filter and a flat protective window in accordance with an embodiment of the disclosure.
- (11) FIG. 13 illustrates cross-sectional view of a lens barrel including the imaging system of FIG. 12 in accordance with an embodiment of the disclosure.
- (12) FIG. 14 illustrates an image of radiation captured by the imaging system of FIG. 12 in accordance with an embodiment of the disclosure.
- (13) FIG. 15 illustrates response plots of radiation captured by the imaging system of FIG. 12 in accordance with an embodiment of the disclosure.
- (14) FIG. 16 illustrates a process of operating an imaging system in accordance with an embodiment of the disclosure.
- (15) Embodiments of the present invention and their advantages are best understood by referring to the detailed description that follows. It should be appreciated that like reference numerals are used to identify like elements illustrated in one or more of the figures.

## DETAILED DESCRIPTION

- (16) Various techniques are provided to reduce reflected radiation in images captured by imaging systems. In some embodiments, an optical element such as a curved protective window (e.g., a zero power curved window (ZPCW)) may be provided in an imaging system. The curved protective window may operate to defocus reflected radiation and thus decrease the magnitude of the reflected radiation (e.g., ghost images) in captured images. For example, the curved protective window may be implemented such that it does not otherwise affect the optical performance of the imaging system when positioned in front of a lens. As a result, manufacturers may include such curved protective windows in imaging systems without requiring changes to lenses of such systems.
- (17) In some embodiments, a filter may be positioned between an image sensor and a lens behind a protective window (e.g., flat, curved, or otherwise) of an imaging system. The filter may be implemented to attenuate (e.g., filter out) wavelengths that are typically passed by anti-reflective coatings (e.g., outside the wavelength ranges typically attenuated by anti-reflective coatings). As a result, reflected radiation in such wavelength ranges may be reduced in captured images.
- (18) Turning now to the drawings, FIG. 1 illustrates a block diagram of an imaging system 100 in accordance with an embodiment of the disclosure. As shown, imaging system 100 includes a housing 151 (e.g., a camera body), an optical system 161, an imager 164, an imager interface 166, a

logic device **168**, user controls **170**, a memory **172**, a communication interface **174**, a machine readable medium **176**, a display **178**, other sensors **180**, and other components **182**.

(19) In various embodiments, imaging system **100** (e.g., an imaging device) may be implemented, for example, as a camera system such as a portable (e.g., handheld) camera system, a small form factor camera system implemented as part of another device, a fixed camera system, and/or other appropriate implementations. Imaging system **100** may be positioned to receive electromagnetic radiation **114** of various wavelengths from a scene **110** (e.g., a field of view of imaging system **100**). In various embodiments, scene **110** may include one or more features **113** such as objects, persons, and/or other features.

(20) Optical system **161** includes one or more optical elements including a curved protective window **102**, a lens **162**, and/or a filter (not shown in FIG. 1). Curved protective window **102** seals an interior volume of housing **151** (e.g., wherein imager **164** is disposed) from the outside environment (e.g., scene **110**). In various embodiments, curved protective window **102** may be comprised of silicon, germanium, zinc sulfide, and/or zinc selenide. In various embodiments, any desired combination of optical elements may be provided (e.g., various components may be included and/or omitted as appropriate for particular implementations).

(21) In the embodiment illustrated in FIG. 1, curved protective window **102** is implemented as a zero power curved window (ZPCW) with a curved inner surface **103** facing lens **162** and imager **164** and having a convex radius of curvature. Curved protective window **102** further includes a curved outer surface **104** facing scene **110** and having a concave radius of curvature. When configured with a ZPCW implementation, curved protective window **102** provides various reflection reducing benefits as discussed herein, but without adversely affecting the focus of optical system **161**.

(22) Lens **162** focuses radiation **114** on imager **164**. Lens **162** includes an inner surface **143** facing imager **164** and an outer surface **144** facing curved protective window **102** and scene **110**.

(23) Imager **164** captures images in response to radiation **114** and includes a top surface **165** facing lens **162**, curved protective window **102**, and scene **110**. In embodiments where imaging system **100** is a thermal imaging system, imager **164** may be a microbolometer-based thermal imager responsive to radiation **114** (e.g., infrared radiation) over a wavelength range of 5 microns to 14 microns (e.g., capturing thermal images over that wavelength range). For example, imager **164** may be implemented by a vacuum package assembly with a focal plane array (FPA) of microbolometer sensors disposed therein and surface **165** may correspond to a lid of the vacuum package assembly.

(24) In various embodiments, one or more anti-reflective coatings may be provided on one or more of surfaces **103**, **104**, **143**, **144**, and/or **165** of optical system **161** and imager **164**. In some cases, such anti-reflective coatings may reduce internal reflections of radiation **114** within imaging system **100** over certain limited wavelength ranges that at least partially overlap with an absorption wavelength range of imager **164** (e.g., the absorption wavelength range corresponding to the spectrum of radiation **114** captured by imager). However, in some cases, at least a portion of the absorption wavelength range may not be affected by the anti-reflective coatings (e.g., radiation **114** in certain wavelength ranges may still be reflected by one or more of surfaces **103**, **104**, **143**, **144**, and/or **165** even with anti-reflective coatings in place).

(25) For example, in some embodiments, anti-reflective coatings on surfaces **103**, **104**, **143**, **144**, and/or **165** may reduce reflections (e.g., permit transmission) over a wavelength range of 8 microns to 14 microns, but may permit some reflections (e.g., exhibit reduced transmission) over a wavelength range of 2 microns to 7 microns. As discussed, when imager **164** is implemented as a thermal imager, it may capture thermal images over a wider wavelength range (e.g., 5 microns to 14 microns). As a result, at least a portion of radiation **114** captured by imager **164** may still be susceptible to reflections (e.g., a wavelength range of 5 microns to 7 or 8 microns) despite the presence of anti-reflective coatings. Various techniques are provided herein to reduce the magnitude of such reflections in images captured by imager **164**.

(26) As shown in FIG. 1, radiation **114** (e.g., scene radiation) enters optical system **161** along a path **115** where it passes through curved protective window **102** and lens **162**, and is received by imager **164** to be captured in an image. At least a portion of radiation **114** reflects off surface **165** of imager **164** (e.g., reflected radiation) and returns through lens **162** to curved protective window **102** along a path **116**. Curved protective window **102** receives the reflected portion of radiation **114** at curved inner surface **103** and returns (e.g., reflects) it back to imager **164** along a path **117**. As discussed, curved inner surface **103** may have a convex radius of curvature (e.g., in contrast to a flat surface). This causes curved inner surface **103** to return the portion of radiation **114** along path **117** in a wide distribution pattern that defocuses the reflected portion of radiation **114** and disperses it over a larger area of imager **164** than the original radiation **114** received along path **115**. In some embodiments, curved protective window **102** may have a focal length greater than 100 meters to provide the defocusing.

(27) As imager **164** captures thermal images of the original radiation **114** received over path **115** and the dispersed reflected portion of radiation **114** received over path **117** (e.g., captured during the same integration period of imager **164**), the magnitude of the reflected portion of radiation **114** will be substantially reduced in the captured thermal images. As a result, ghost images associated with the reflected portion of radiation **114** may be accordingly reduced.

(28) In some embodiments, curved protective window **102** may be implemented using the following equation 1:

$$(29) \quad \phi = (n - 1) \left[ \frac{1}{R_1} - \frac{1}{R_2} + \frac{(n - 1)d}{nR_1R_2} \right] \quad (\text{equation 1})$$

(30) In equation 1,  $\phi$  is the optical power,  $n$  is a refractive index of the material of curved protective window **102**,  $R_1$  is a radius of curvature of convex curved inner surface **103**,  $R_2$  is a radius of curvature of concave curved outer surface **104**,  $d$  is a thickness of curved protective window **102**.

For example, a ZPCW curved protective window **102** implemented with germanium, a thickness  $d$  of 2 mm, and a radius of curvature  $R_1$  of 50 mm, would have a radius of curvature  $R_2$  of 48.5 mm.

(31) Imager **164** may include an array of sensors for capturing images (e.g., image frames) of scene **110**. For example, in some embodiments, imager **164** may be a thermal imager including an FPA disposed in a vacuum package assembly and including an array of unit cells and a read out integrated circuit (ROIC). Each unit cell may be provided with an infrared detector (e.g., a microbolometer or other appropriate sensor) and associated circuitry to provide image data for a pixel of a captured thermal image. In some embodiments, imager **164** may also include one or more analog-to-digital converters for converting analog signals captured by the sensors into digital data (e.g., pixel values) to provide the captured images. Further descriptions of ROICs and infrared sensors (e.g., microbolometer circuits) may be found in U.S. Pat. No. 6,028,309 issued Feb. 22, 2000, which is incorporated herein by reference in its entirety.

(32) Imager **164** is primarily described herein as a thermal imager configured to capture thermal wavelengths. However, it will be appreciated that imagers associated with other wavelengths are also contemplated where appropriate (e.g., visible light, ultraviolet, microwave, and/or others).

(33) Imager interface **166** provides the captured images to logic device **168** which may be used to process the images, store the original and/or processed images in memory **172**, and/or retrieve stored images from memory **172**. In some embodiments, imager interface **166** may provide the captured images directly to memory **172** as shown.

(34) Although a single imager **164** is illustrated, a plurality of imagers **164** and associated components may be provided in other embodiments. For example, different imagers **164** may be provided to capture the same or different wavelengths of radiation **114** simultaneously to provide associated captured images in some embodiments.

(35) Logic device **168** may include, for example, a microprocessor, a single-core processor, a multi-core processor, a microcontroller, a programmable logic device configured to perform processing operations, a digital signal processing (DSP) device, one or more memories for storing

executable instructions (e.g., software, firmware, or other instructions), and/or any other appropriate combinations of devices and/or memory to perform any of the various operations described herein. Logic device **168** is configured to interface and communicate with the various components of imaging system **100** to perform various method and processing steps described herein. In various embodiments, processing instructions may be integrated in software and/or hardware as part of logic device **168**, or code (e.g., software and/or configuration data) which may be stored in memory **172** and/or a machine readable medium **176**. In various embodiments, the instructions stored in memory **172** and/or machine readable medium **176** permit logic device **168** to perform the various operations discussed herein and/or control various components of imaging system **100** for such operations.

(36) Memory **172** may include one or more memory devices (e.g., one or more memories) to store data and information. The one or more memory devices may include various types of memory including volatile and non-volatile memory devices, such as RAM (Random Access Memory), ROM (Read-Only Memory), EEPROM (Electrically-Erasable Read-Only Memory), flash memory, fixed memory, removable memory, and/or other types of memory.

(37) Machine readable medium **176** (e.g., a memory, a hard drive, a compact disk, a digital video disk, or a flash memory) may be a non-transitory machine readable medium storing instructions for execution by logic device **168**. In various embodiments, machine readable medium **176** may be included as part of imaging system **100** and/or separate from imaging system **100**, with stored instructions provided to imaging system **100** by coupling the machine readable medium **176** to imaging system **100** and/or by imaging system **100** downloading (e.g., via a wired or wireless link) the instructions from the machine readable medium (e.g., containing the non-transitory information).

(38) Logic device **168** may be configured to process captured images and provide them to display **178** for presentation to and viewing by the user. Display **178** may include a display device such as a liquid crystal display (LCD), an organic light-emitting diode (OLED) display, and/or other types of displays as appropriate to display images and/or information to the user of imaging system **100**. Logic device **168** may be configured to display images and information on display **178**. For example, logic device **168** may be configured to retrieve images and information from memory **172** and provide images and information to display **178** for presentation to the user of imaging system **100**. Display **178** may include display electronics, which may be utilized by logic device **168** to display such images and information.

(39) User controls **170** may include any desired type of user input and/or interface device having one or more user actuated components, such as one or more buttons, slide bars, knobs, keyboards, joysticks, and/or other types of controls that are configured to generate one or more user actuated input control signals. In some embodiments, user controls **170** may be integrated with display **178** as a touchscreen to operate as both user controls **170** and display **178**. Logic device **168** may be configured to sense control input signals from user controls **170** and respond to sensed control input signals received therefrom. In some embodiments, portions of display **178** and/or user controls **170** may be implemented by appropriate portions of a tablet, a laptop computer, a desktop computer, and/or other types of devices.

(40) In various embodiments, user controls **170** may be configured to include one or more other user-activated mechanisms to provide various other control operations of imaging system **100**, such as auto-focus, menu enable and selection, field of view (FoV), brightness, contrast, gain, offset, spatial, temporal, and/or various other features and/or parameters.

(41) Imaging system **100** may include various types of other sensors **180** including, for example, microphones, navigation sensors, temperature sensors, and/or other sensors as appropriate.

(42) Logic device **168** may be configured to receive and pass images from imager interface **166** and signals and data from sensors **180**, and/or user controls **170** to a host system and/or other external devices (e.g., remote systems) through communication interface **174** (e.g., through wired and/or

wireless communications). In this regard, communication interface **174** may be implemented to provide wired communication over a cable and/or wireless communication over an antenna. For example, communication interface **174** may include one or more wired or wireless communication components, such as an Ethernet connection, a wireless local area network (WLAN) component based on the IEEE 802.11 standards, a wireless broadband component, mobile cellular component, a wireless satellite component, or various other types of wireless communication components including radio frequency (RF), microwave frequency (MWF), and/or infrared frequency (IRF) components configured for communication with a network. As such, communication interface **174** may include an antenna coupled thereto for wireless communication purposes. In other embodiments, the communication interface **174** may be configured to interface with a DSL (e.g., Digital Subscriber Line) modem, a PSTN (Public Switched Telephone Network) modem, an Ethernet device, and/or various other types of wired and/or wireless network communication devices configured for communication with a network.

(43) In some embodiments, a network may be implemented as a single network or a combination of multiple networks. For example, in various embodiments, the network may include the Internet and/or one or more intranets, landline networks, wireless networks, and/or other appropriate types of communication networks. In another example, the network may include a wireless telecommunications network (e.g., cellular phone network) configured to communicate with other communication networks, such as the Internet. As such, in various embodiments, imaging system **100** and/or its individual associated components may be associated with a particular network link such as for example a URL (Uniform Resource Locator), an IP (Internet Protocol) address, and/or a mobile phone number.

(44) Imaging system **100** may include various other components **182** such as speakers, additional displays, visual indicators (e.g., recording indicators), vibration actuators, a battery or other power supply (e.g., rechargeable or otherwise), and/or additional components as appropriate for particular implementations.

(45) Although various features of imaging system **100** are illustrated together in FIG. **1**, any of the various illustrated components and subcomponents may be implemented in a distributed manner and used remotely from each other as appropriate (e.g., through appropriate wired and/or wireless network communication).

(46) FIGS. **2** to **6** will now be discussed in relation to an imaging system **200** implemented in the manner of imaging system **100** of FIG. **1** but with an optical system **261** in place of optical system **161**. Optical system **261** includes one or more optical elements including a flat protective window **202**, lens **162** (e.g., implemented in the manner of FIG. **1**), and/or a filter (not shown in FIG. **2**). In various embodiments, anti-reflective coatings may be provided on any of the various surfaces of optical elements in optical system **261**.

(47) Flat protective window **202** seals an interior volume of housing **151** (not shown in FIG. **2**) similar to curved protective window **102** of FIG. **1**. Flat protective window **202** is implemented with a flat inner surface **203** facing lens **162** and imager **164**. Flat protective window **202** further includes a flat outer surface **204** facing scene **110**.

(48) FIGS. **2** and **3** illustrate various paths of radiation **114** in imaging system **200** in accordance with embodiments of the disclosure. Similar to FIG. **1**, radiation **114** enters optical system **261** along path **115** where it passes through flat protective window **202** and lens **162**, and is received by imager **164** to be captured in an image. At least a portion of radiation **114** reflects off surface **165** of imager **164** and returns to flat protective window **202** along a path **116**. Flat protective window **202** receives the reflected portion of radiation **114** at flat inner surface **203** and returns it back to imager **164** along a path **217**. However, flat inner surface **203** does not defocus or disperse the returned reflected portion of radiation **114** in the manner of curved inner surface **103**. Rather, the reflected portion of radiation **114** returned along path **217** remains focused due to its reflection off flat inner surface **203** in a narrow distribution pattern. As a result, ghost images associated with the reflected



portion of radiation **114** may appear in images captured by imager **164** unless otherwise mitigated by a filter as discussed herein. The presence of such ghost images can be appreciated upon review of FIGS. **4** to **6**.

(49) FIG. **4** illustrates a diagram **400** of a polychromatic fast Fourier transform of a point spread function of the reflected portion of radiation returned along path **217** and captured by imager **164** in imaging system **200** for thermal wavelengths in accordance with an embodiment of the disclosure. As shown, diagram **400** includes a large peak **410** corresponding to the reflected portion of radiation returned along path **217** corresponding to feature **113** of scene **110**.

(50) FIG. **5** illustrates a thermal image **500** (e.g., an irradiance map) of radiation **114** captured by imager **164** in imaging system **200** for thermal wavelengths in accordance with an embodiment of the disclosure. Thermal image **500** includes a primary representation **510** of feature **113** corresponding to radiation **114** captured along path **115**. Thermal image **500** further includes a secondary representation **520** of feature **113** corresponding to the reflected portion of radiation **114** captured along path **217** (e.g., a ghost image of feature **113**). Secondary representation **520** is noticeable in thermal image **500** and demonstrates the existence of a ghost image in this embodiment.

(51) FIG. **6** illustrates response plots **602** and **604** taken along horizontal and vertical axes, respectively, of imager **164** for radiation **114** captured by imager **164** in imaging system **200** for thermal wavelengths in accordance with an embodiment of the disclosure. As shown, response plot **602** includes primary representation **510** and secondary representation **520** of feature **113** in a manner as discussed with regard to FIG. **5**. In FIG. **6**, response plots **602** and **604** are logarithmic and normalized to the peak radiation value received by imager **164**. As shown, secondary representation **520** has a magnitude of approximately 1 percent of primary representation **510** which constitutes a significant reading compared to Noise Equivalent Temperature Difference (NETD) of a typical long wave infrared camera.

(52) FIGS. **7** to **11** will now be discussed in relation to imaging system **100** with optical system **161** implemented in the manner of FIG. **1**. For example, FIGS. **7** and **8** illustrate various paths of radiation **114** in imaging system **100** in accordance with embodiments of the disclosure.

(53) As shown in FIG. **7**, radiation **114** may enter optical system **161** through curved protective window **102** over multiple paths **115**. As discussed, curved protective window **102** may be implemented as a ZPCW which provides reflection reducing benefits as discussed, but without adversely affecting the focus of optical system **161**. This is evident from the ray traces of paths **115**. As shown, ray traces corresponding to radiation **114** pass through curved protective window **102** without affecting their focus. For example, the ray traces entering through curved outer surface **104** are substantially unchanged when exiting through curved inner surface **103**.

(54) As shown in FIG. **8**, the convex radius of curvature of curved inner surface **103** causes the reflected portion of radiation **114** to be returned along path **117** in a wide distribution pattern that defocuses the reflected portion of radiation **114** and disperses it over a large area of imager **164**. This wide distribution pattern of FIG. **8** contrasts with the narrow distribution pattern of FIG. **3**. As shown and discussed with regard to FIG. **3**, flat inner surface **203** causes the reflected portion of radiation **114** to be returned along path **217** in a narrow and focused distribution pattern which results in prominent ghost images associated with the reflected portion of radiation **114**.

(55) FIG. **9** illustrates a diagram **900** of a polychromatic fast Fourier transform of a point spread function of the reflected portion of radiation returned along path **117** and captured by imager **164** in imaging system **100** for thermal wavelengths in accordance with an embodiment of the disclosure. As shown, diagram **900** includes a small peak **910** corresponding to the reflected portion of radiation returned along path **117** corresponding to feature **113** of scene **110**. Upon comparison, it will be appreciated that peak **910** of FIG. **9** is smaller than peak **410** of FIG. **4**, thus demonstrating a reduced magnitude of the reflected portion of radiation **114** in optical system **161** in comparison with optical system **261**.

(56) FIG. 10 illustrates a thermal image **1000** of radiation **114** captured by imager **164** in imaging system **100** for thermal wavelengths in accordance with an embodiment of the disclosure. Thermal image **1000** includes a primary representation **1010** of feature **113** corresponding to radiation **114** captured along path **115**. Thermal image **1000** further includes a secondary representation **1020** of feature **113** corresponding to the reflected portion of radiation **114** captured along path **117** (e.g., a ghost image of feature **113**). Upon comparison, it will be appreciated that secondary representation **1020** of FIG. 10 is less noticeable than secondary representation **520** of FIG. 5, thus demonstrating a reduced magnitude of the reflected portion of radiation **114** in optical system **161** in comparison with optical system **261**.

(57) FIG. 11 illustrates response plots **1102** and **1104** taken along horizontal and vertical axes, respectively, of imager **164** for radiation **114** captured by imager **164** in imaging system **100** for thermal wavelengths in accordance with an embodiment of the disclosure. As shown, response plot **1102** includes primary representation **1010** and secondary representation **1020** of feature **113** in a manner as discussed with regard to FIG. 10. Upon comparison, it will be appreciated that secondary representation **1020** in response plot **1102** of FIG. 11 is smaller than secondary representation **520** in response plot **602** of FIG. 6 (e.g., reduced by at least one order of magnitude), thus demonstrating a reduced magnitude of the reflected portion of radiation **114** in optical system **161** in comparison with optical system **261**.

(58) FIGS. 12 to 15 will now be discussed in relation to an imaging system **1200** implemented in the manner of imaging system **100** of FIG. 1 but with an optical system **1261** in place of optical system **161**. Optical system **1261** includes one or more optical elements including flat protective window **202** (e.g., implemented in the manner of FIGS. 2 and 3), lens **162** (e.g., implemented in the manner of FIG. 1), and a filter **1202**. In various embodiments, anti-reflective coatings may be provided on any of the various surfaces of optical elements in optical system **1261**.

(59) In various embodiments, filter **1202** may be implemented as a long wave pass (LWP) filter, a short wave cut (SWC) filter, and/or other filter type to reduce the reflected portion of radiation **114** reflected from surface **165** of imager **164**. For example, in the case of a thermal imaging system, filter **1202** may be configured to maximize transmission (e.g., pass radiation) in longer wavelengths corresponding to those in which anti-reflective coatings are effective (e.g., 8 to 14 microns) and minimize transmission (e.g., filter or attenuate radiation) in shorter wavelengths corresponding to those in which anti-reflective coatings are not effective (e.g., 2 to 7 microns).

(60) For example, FIG. 12 illustrates imaging system **1200** including filter **1202** and flat protective window **202** in accordance with an embodiment of the disclosure. As shown in FIG. 12, filter **1202** is positioned between imager **164** and lens **162** to receive the reflected portion of radiation **114** from imager **164** along path **116**. As a result, filter **1202** may attenuate the reflected portion of radiation **114** received along path **116** and reduce or prevent such reflections from being received or returned by flat inner surface **203** of flat protective window **202** along path **117**. As a result, ghost images associated with such reflections may be reduced or eliminated.

(61) Other embodiments are also contemplated. For example, FIG. 13 illustrates a cross-sectional view of a lens barrel **1300** including a portion of imaging system **1200** with filter **1202** positioned behind lens **162** in accordance with an embodiment of the disclosure.

(62) FIG. 14 illustrates a thermal image **1400** of radiation **114** captured by imager **164** in imaging system **1200** for thermal wavelengths in accordance with an embodiment of the disclosure. Thermal image **1400** includes a primary representation **1410** of feature **113** corresponding to radiation **114** captured along path **115**. Thermal image **1400** further includes a secondary representation **1420** of feature **113** corresponding to the reflected portion of radiation **114** captured along path **117** (e.g., a ghost image of feature **113**). Upon comparison, it will be appreciated that secondary representation **1420** of FIG. 10 is less noticeable than with secondary representation **520** of FIG. 5, thus demonstrating a reduced magnitude of the reflected portion of radiation **114** in optical system **1261** in comparison with optical system **261**, even with flat protective window **202**

in place in both systems.

(63) FIG. 15 illustrates response plots **1502** and **1504** taken along horizontal and vertical axes, respectively, of imager **164** for radiation **114** captured by imager **164** in imaging system **1200** for thermal wavelengths in accordance with an embodiment of the disclosure. As shown, response plot **1502** includes primary representation **1410** and secondary representation **1420** of feature **113** in a manner as discussed with regard to FIG. 14. Upon comparison, it will be appreciated that secondary representation **1420** in response plot **1502** of FIG. 11 is smaller than secondary representation **520** in response plot **602** of FIG. 6 (e.g., reduced by at least one order of magnitude), thus demonstrating a reduced magnitude of the reflected portion of radiation **114** in optical system **1261** in comparison with optical system **261**.

(64) Although imaging systems **100**, **200**, and **1200** have been described separately, some or all of their components may be combined in various embodiments. For example, in some embodiments, curved protective window **102** and filter **1202** may be provided in the same optical system of an imaging system to provide for both defocusing and filtering of reflected radiation.

(65) FIG. 16 illustrates a process of operating various components of imaging systems **100**, **200**, and **1200** in accordance with an embodiment of the disclosure. As further discussed below, blocks **1600** correspond to certain operations performed using imaging system **100** with curved protective window **102** and certain operations performed using imaging systems **200/1200** with flat protective window **202**. Blocks **1650** correspond to certain operations performed using imaging systems **200/1200** with flat protective window **202** and certain operations performed using imaging system **1200** with filter **1202**.

(66) In block **1602**, curved protective window **102** or flat protective window **202** receives and passes radiation **114** from scene **110** along path **115**. In block **1604**, lens **162** focuses radiation **114** and passes it along path **115**.

(67) If filter **1202** is present (block **1606**), then block **1608** is additionally performed in which filter **1202** also passes radiation **114** along path **115**.

(68) In block **1610**, imager **164** receives radiation **114** from path **115**. In block **1612**, surface **165** of imager **164** reflects a portion of radiation **114** along path **116** toward curved protective window **102** or flat protective window **202**.

(69) If filter **1202** is not present (block **1614**), the process continues to block **1616**. In block **1616**, curved inner surface **103** of curved protective window **102** receives the reflected portion of radiation **114** from path **116** (e.g., after it has passed back through lens **162**).

(70) In block **1618**, curved inner surface **103** causes the reflected portion of radiation **114** to be returned along path **117** in a wide distribution pattern that defocuses the reflected portion of radiation **114** and disperses it over a large area of imager **165** as discussed.

(71) If filter **1202** is present (block **1614**), the process continues to block **1620**. In block **1620**, filter **1202** receives and attenuates the reflected portion of radiation **114** received along path **116** as discussed. In block **1622**, flat inner surface **203** of flat protective window **202** receives any remaining reflected portion of radiation **114** from path **116** (e.g., after it has passed back through lens **162**).

(72) In block **1624**, flat inner surface **203** causes the remaining reflected portion of radiation **114** to be returned along path **217** in a narrow distribution pattern as discussed. However, as also discussed, this remaining reflected portion of radiation **114** may still be substantially reduced as illustrated in FIGS. 14 and 15.

(73) In block **1626**, imager **164** captures one or more images of the originally received radiation **114** from path **115** and the reflected radiation from path **117** and/or **217**. As discussed, the resulting thermal images may exhibit reduced ghost images associated with the reflected portion of radiation **114** as a result of the defocusing performed by curved inner surface **103** of curved protective window **102** and/or the attenuation performed by filter **1202**.

(74) Where applicable, various embodiments provided by the present disclosure can be

implemented using hardware, software, or combinations of hardware and software. Also where applicable, the various hardware components and/or software components set forth herein can be combined into composite components comprising software, hardware, and/or both without departing from the spirit of the present disclosure. Where applicable, the various hardware components and/or software components set forth herein can be separated into sub-components comprising software, hardware, or both without departing from the spirit of the present disclosure. In addition, where applicable, it is contemplated that software components can be implemented as hardware components, and vice-versa.

(75) Software in accordance with the present disclosure, such as program code and/or data, can be stored on one or more computer readable mediums. It is also contemplated that software identified herein can be implemented using one or more general purpose or specific purpose computers and/or computer systems, networked and/or otherwise. Where applicable, the ordering of various steps described herein can be changed, combined into composite steps, and/or separated into sub-steps to provide features described herein.

(76) Embodiments described above illustrate but do not limit the invention. It should also be understood that numerous modifications and variations are possible in accordance with the principles of the present invention. Accordingly, the scope of the invention is defined only by the following claims.

## Claims

1. A system comprising: an optical element configured to pass radiation from a scene; an imager configured to capture images in response to the scene radiation, wherein the imager is a thermal imager disposed in a vacuum package comprising a lid configured to pass the scene radiation to the imager and reflect at least a portion of the scene radiation to the optical element; wherein the optical element comprises an inner surface with a convex radius of curvature facing the imager and configured to receive and return the reflected radiation toward the imager in a distribution pattern to reduce a magnitude of the reflected radiation in the captured images; and wherein the optical element is a zero power curved window comprising an outer surface with a concave radius of curvature facing the scene.
2. The system of claim 1, further comprising: a housing; wherein the imager is disposed within an interior of the housing; and wherein the optical element is a protective window configured to pass the scene radiation to the interior of the housing.
3. The system of claim 2, further comprising a lens positioned between the protective window and the imager and configured to focus the scene radiation on the imager.
4. The system of claim 1, wherein: the optical element comprises an anti-reflective coating configured to pass the scene radiation over a first wavelength range within an absorption wavelength range of the imager; and the reflected radiation comprises a second wavelength range separate from the first wavelength range and within the absorption wavelength range of the imager.
5. The system of claim 1, wherein the optical element has a focal length greater than 100 meters.
6. The system of claim 5, wherein the optical element is comprised of silicon, germanium, zinc sulfide, and/or zinc selenide.
7. The system of claim 1, further comprising a filter disposed between the optical element and the imager and configured to attenuate the reflected radiation.
8. A method comprising: passing radiation from a scene by an optical element; passing the scene radiation to an imager through a lid, wherein the imager is a thermal imager disposed in a vacuum package comprising the lid; capturing images in response to the scene radiation by the imager; reflecting, by the lid, at least a portion of the scene radiation to the optical element by the imager; receiving the reflected radiation at an inner surface of the optical element having a convex radius of curvature facing the imager; returning the reflected radiation toward the imager by the inner surface

of the optical element in a distribution pattern to reduce a magnitude of the reflected radiation in the captured images; and wherein the optical element is a zero power curved window comprising an outer surface with a concave radius of curvature facing the scene.

9. The method of claim 8, wherein: the imager is disposed within an interior of a housing; the optical element is a protective window; and the passing by the optical element comprises passing the scene radiation to the interior of the housing by the protective window.

10. The method of claim 9, further comprising focusing the scene radiation on the imager by a lens positioned between the protective window and the imager.

11. The method of claim 8, wherein: the optical element comprises an anti-reflective coating configured to perform the passing over a first wavelength range within an absorption wavelength range of the imager; and the reflected radiation comprises a second wavelength range separate from the first wavelength range and within the absorption wavelength range of the imager.

12. The method of claim 8, wherein the optical element has a focal length greater than 100 meters.

13. The method of claim 12, wherein the optical element is comprised of silicon, germanium, zinc sulfide, and/or zinc selenide.

14. The method of claim 8, further comprising attenuating the reflected radiation by a filter disposed between the optical element and the imager.

15. A system configured to perform the method of claim 8, the system comprising: the optical element; the imager; and the vacuum package.

16. A method comprising: passing radiation from a scene by an optical element to an interior of a housing, wherein the optical element is a protective window; passing the scene radiation to an imager through a lid, wherein the imager is a thermal imager disposed in a vacuum package comprising the lid, wherein the vacuum package is disposed within the interior of the housing; capturing images in response to the scene radiation by the imager; reflecting, by the lid, at least a portion of the scene radiation to the optical element by the imager; receiving the reflected radiation at an inner surface of the protective window having a convex radius of curvature facing the imager; and reducing, by the optical element, a magnitude of the reflected radiation in the captured images, wherein the reducing comprises returning the reflected radiation toward the imager by the inner surface of the protective window in a distribution pattern to reduce the magnitude of the reflected radiation in the captured images.

17. The method of claim 16, further comprising attenuating the reflected radiation by a filter disposed between the optical element and the imager.

18. The method of claim 16, wherein the optical element is a zero power curved window comprising an outer surface with a concave radius of curvature facing the scene.

19. A system configured to perform the method of claim 16, the system comprising: the optical element; the imager; and the vacuum package.

20. The method of claim 16, wherein: the optical element comprises an anti-reflective coating configured to perform the passing over a first wavelength range within an absorption wavelength range of the imager; and the reflected radiation comprises a second wavelength range separate from the first wavelength range and within the absorption wavelength range of the imager.

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